

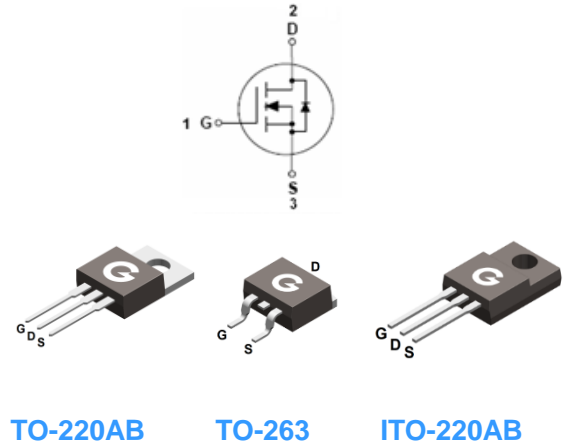
### Features

- Low on-resistance
- Low gate charge
- Extremely high dv/dt capability
- HBM: JESD22-A114-B: 1B

HF

### Mechanical Data

- Case: TO-220AB, TO-263, ITO-220AB
- Molding Compound: UL Flammability Classification Rating 94V-0
- Terminals: Matted-Tin plated; Solderable Per MIL-STD-202, Method 208



### Ordering Information

Part Number	Package	Shipping Quantity	Marking Code
BL7N60	TO-220AB	50 pcs / Tube	7N60
BL7N60B	TO-263	50 pcs / Tube or 800 pcs / Tape & Reel	7N60B
BL7N60F	ITO-220AB	50 pcs / Tube	7N60F

### Maximum Ratings (@ $T_C = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Value	Unit
Drain-to-Source Voltage	$V_{DSS}$	600	V
Gate-to-Source Voltage	$V_{GSS}$	$\pm 30$	V
Continuous Drain Current ( $T_C = 25^\circ\text{C}$ )	$I_D$	7	A
Continuous Drain Current ( $T_C = 100^\circ\text{C}$ )		4.4	A
Pulsed Drain Current ( $t_p = 10\mu\text{s}$ , $T_C = 25^\circ\text{C}$ )	$I_{DM}$	28	A
Single Pulse Avalanche Energy <sup>2</sup>	$E_{AS}$	350	mJ
Power Dissipation (TO-220AB, $T_C = 25^\circ\text{C}$ )	$P_D$	139	W
Power Dissipation (TO-263, $T_C = 25^\circ\text{C}$ )		139	W
Power Dissipation (ITO-220AB, $T_C = 25^\circ\text{C}$ )		45	W
Operating Junction Temperature Range	$T_J$	-55 ~ +150	$^\circ\text{C}$
Storage Temperature Range	$T_{STG}$	-55 ~ +150	$^\circ\text{C}$

### Thermal Characteristics

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal Resistance Junction-to-Case (TO-220AB, TO-263)	R <sub>θJC</sub>	-	0.6	0.9	°C/W
Thermal Resistance Junction-to-Case (ITO-220AB)		-	2.6	2.8	°C/W
Thermal Resistance Junction-to-Air (TO-220AB, TO-263)	R <sub>θJA</sub>	-	-	50	°C/W
Thermal Resistance Junction-to-Air (ITO-220AB)		-	-	62.5	°C/W

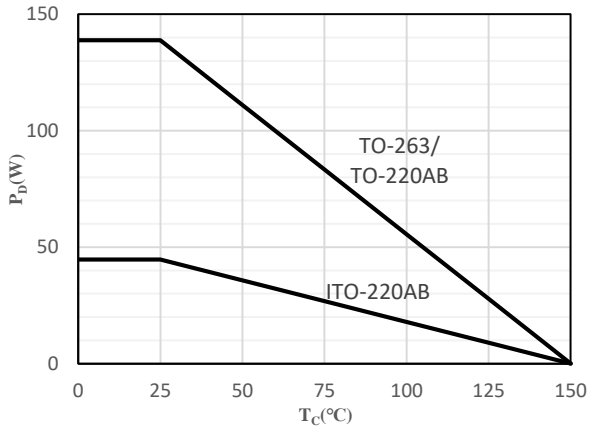
### Electrical Characteristics (@ T<sub>A</sub> = 25°C unless otherwise specified)

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Unit
<b>Static Characteristics</b>						
V <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA	600	-	-	V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 600V, V <sub>GS</sub> = 0V	-	-	1	μA
I <sub>GSS</sub>	Gate-Body Leakage Current	V <sub>GS</sub> = ±30V, V <sub>DS</sub> = 0V	-	-	±100	nA
<b>On Characteristics</b>						
R <sub>DS(ON)</sub>	Drain-Source On-resistance *1	V <sub>GS</sub> = 10V, I <sub>D</sub> = 3.5A	-	1.15	1.45	Ω
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250μA	2	3.1	4	V
R <sub>G</sub>	Gate Resistance	V <sub>GS</sub> = 0V, f = 1MHz	-	3.3	-	Ω
<b>Dynamic Characteristics</b>						
C <sub>ISS</sub>	Input Capacitance	V <sub>GS</sub> = 0V V <sub>DS</sub> = 25V f = 1MHz	-	1148	-	pF
C <sub>OSS</sub>	Output Capacitance		-	87	-	
C <sub>RSS</sub>	Reverse Transfer Capacitance		-	1.4	-	
<b>Switching Characteristics</b>						
t <sub>d(ON)</sub>	Turn-on Delay Time	V <sub>DD</sub> = 325V V <sub>GS</sub> = 15V I <sub>D</sub> = 3.5A R <sub>G</sub> = 3.3Ω	-	18	-	ns
t <sub>r</sub>	Turn-on Rise Time		-	30	-	
t <sub>d(OFF)</sub>	Turn-Off Delay Time		-	37	-	
t <sub>f</sub>	Turn-Off Fall Time		-	76	-	
Q <sub>G</sub>	Total Gate-Charge	V <sub>DD</sub> = 520V V <sub>GS</sub> = 10V I <sub>D</sub> = 7A	-	21.2	-	nC
Q <sub>GS</sub>	Gate to Source Charge		-	5.8	-	
Q <sub>GD</sub>	Gate to Drain (Miller) Charge		-	7.6	-	
<b>Source-Drain Diode Characteristics</b>						
V <sub>SD</sub>	Diode Forward Voltage *1	I <sub>SD</sub> = 7A, V <sub>GS</sub> = 0V	-	0.84	1.4	V
t <sub>rr</sub>	Reverse Recovery Time	I <sub>SD</sub> = 7A, V <sub>R</sub> = 400V	-	310	-	ns
Q <sub>rr</sub>	Reverse Recovery Charge	di/dt = 100A/μs	-	2.7	-	μC

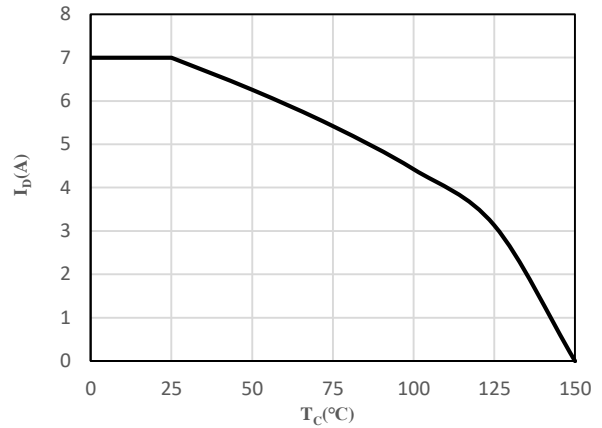
Notes:

- The data tested by pulsed, pulse width ≤ 300μs, duty cycle ≤ 2%
- The E<sub>AS</sub> data shows Max. rating. The test condition is V<sub>DD</sub> = 100V, V<sub>GS</sub> = 10V, L = 10mH

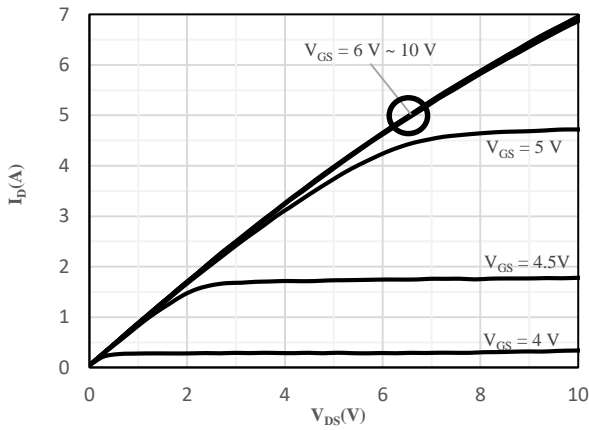
**Ratings and Characteristics Curves** (@  $T_A = 25^\circ\text{C}$  unless otherwise specified)



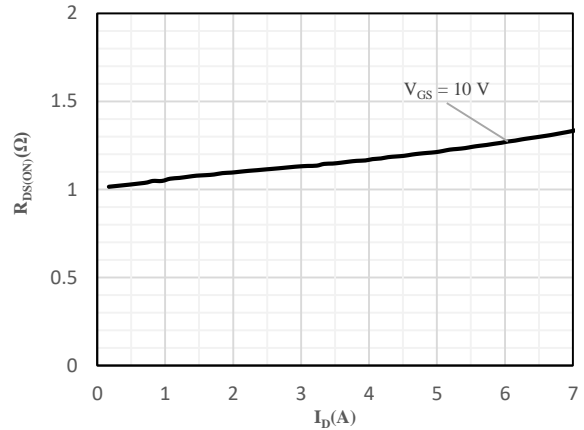
**Fig 1 Power Dissipation**



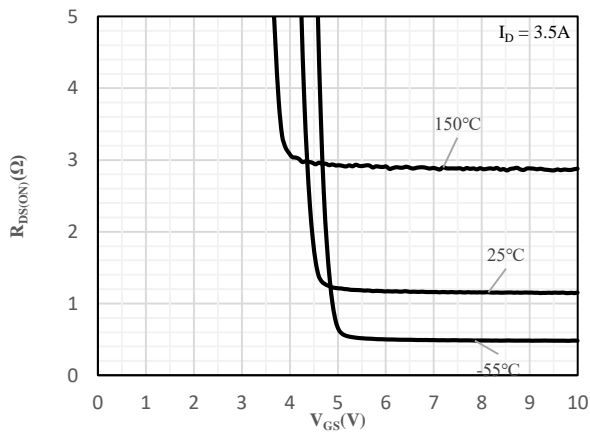
**Fig 2 Drain Current**



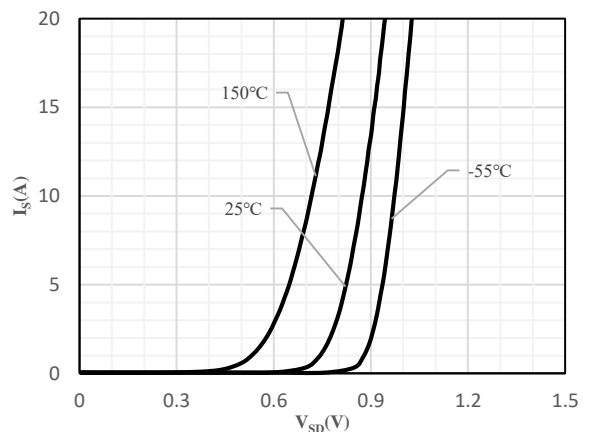
**Fig 3 Typical Output Characteristics**



**Fig 4 On-Resistance vs. Drain Current and Gate Voltage**



**Fig 5 On-Resistance vs. Gate-Source Voltage**



**Fig 6 Body-Diode Characteristics**

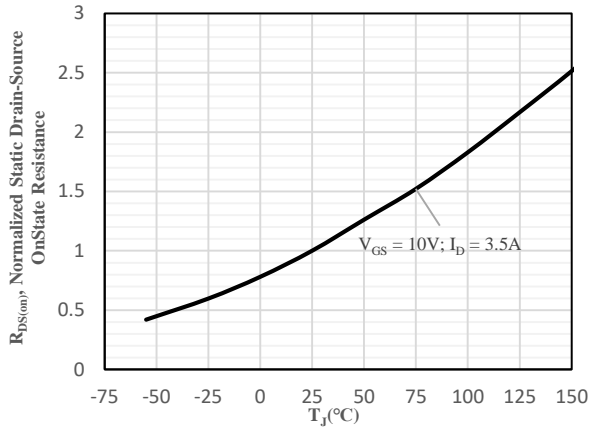


Fig 7 Normalized On-Resistance vs. Junction Temperature

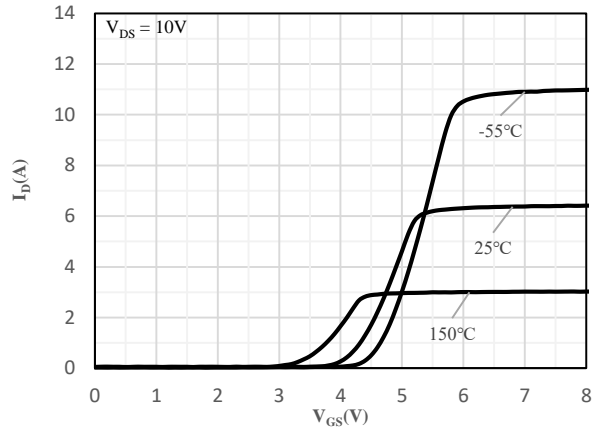


Fig 8 Transfer Characteristics

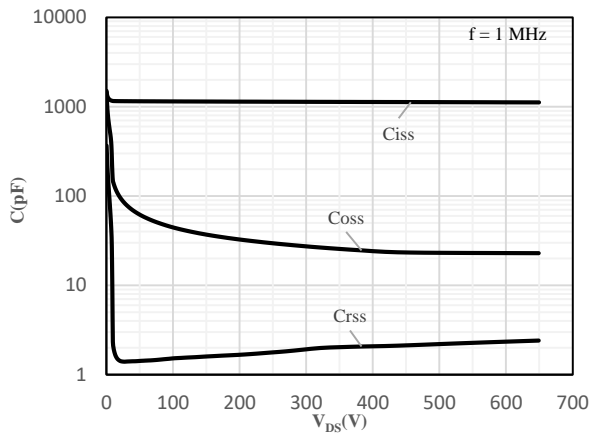


Fig 9 Capacitance Characteristics

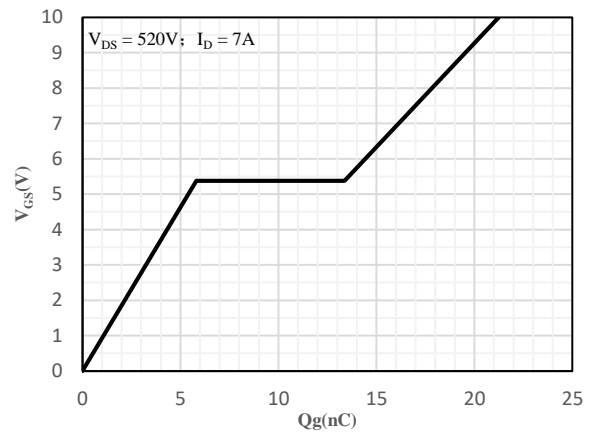


Fig 10 Gate-Charge Characteristics

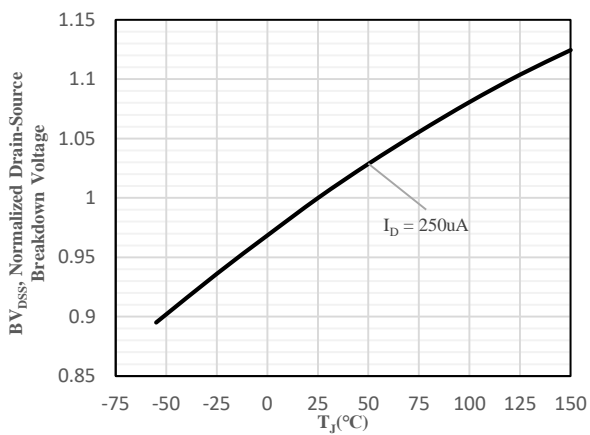


Fig 11 Normalized Breakdown Voltage vs. Junction Temperature

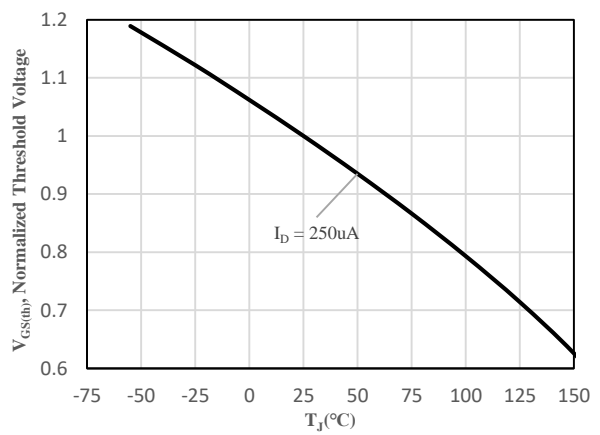


Fig 12 Normalized  $V_{GS(th)}$  vs. Junction Temperature

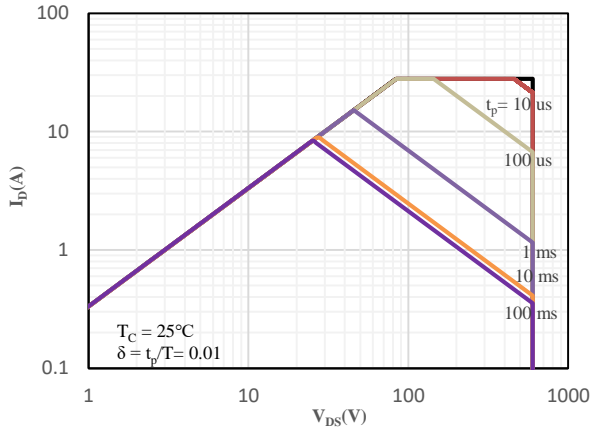


Fig 13 Safe Operation Area (TO-220AB / TO-263)

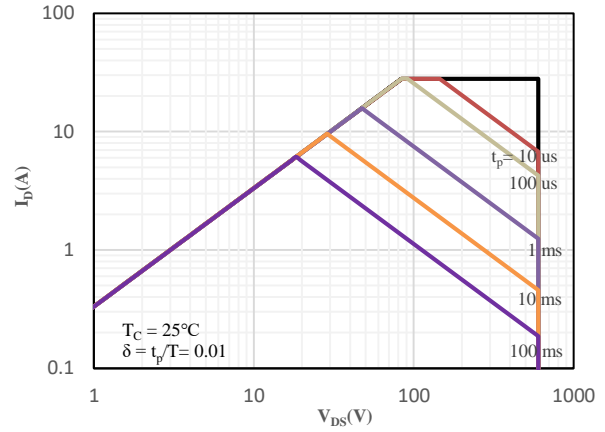


Fig 14 Safe Operation Area (ITO-220AB)

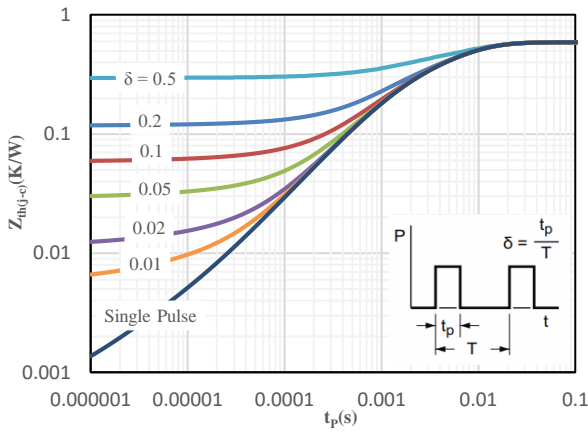


Fig 15 Maximum transient thermal impedance  
(TO-220AB / TO-263)

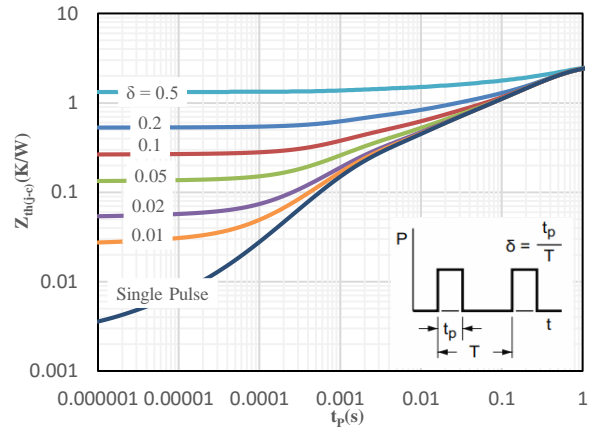
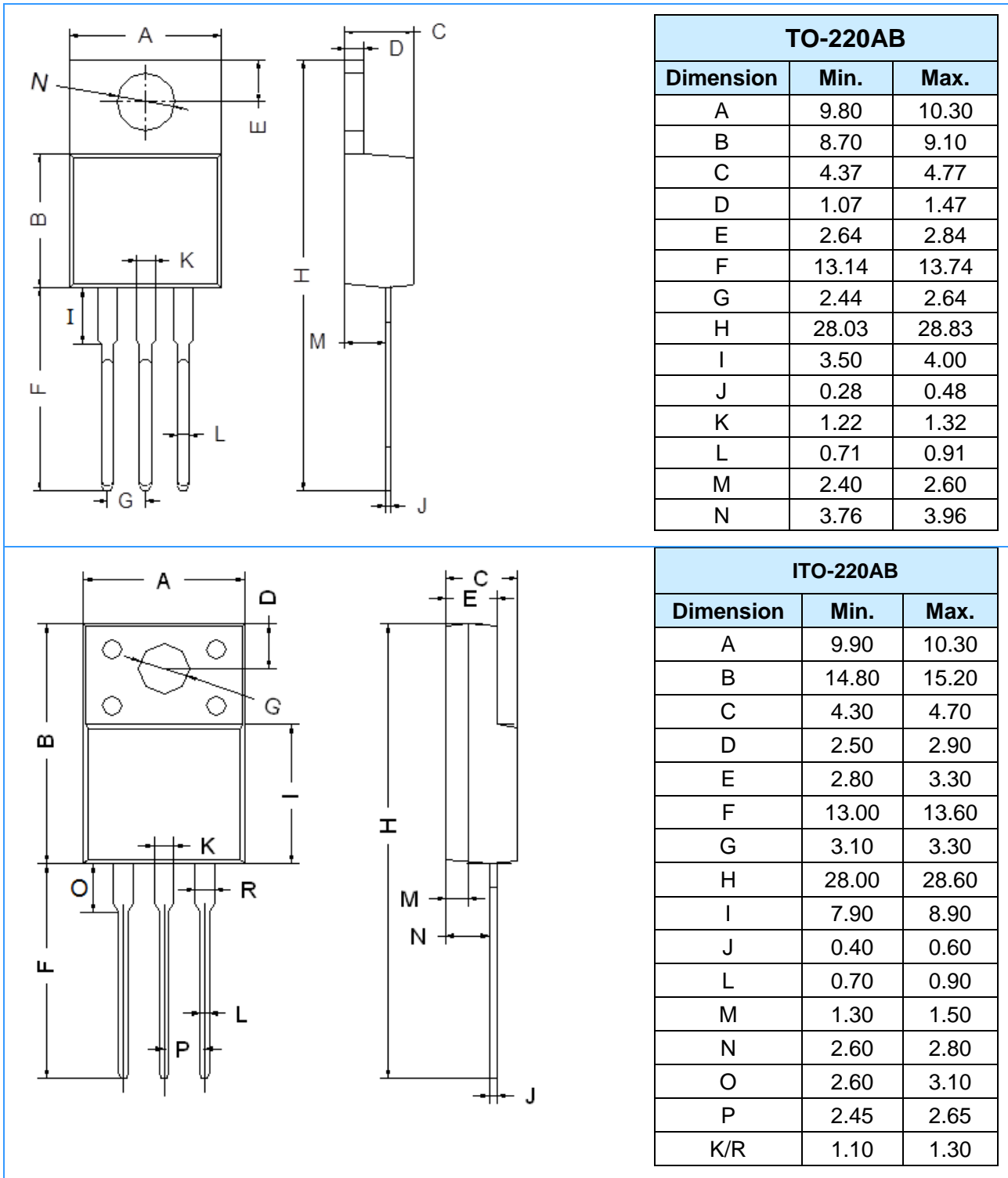
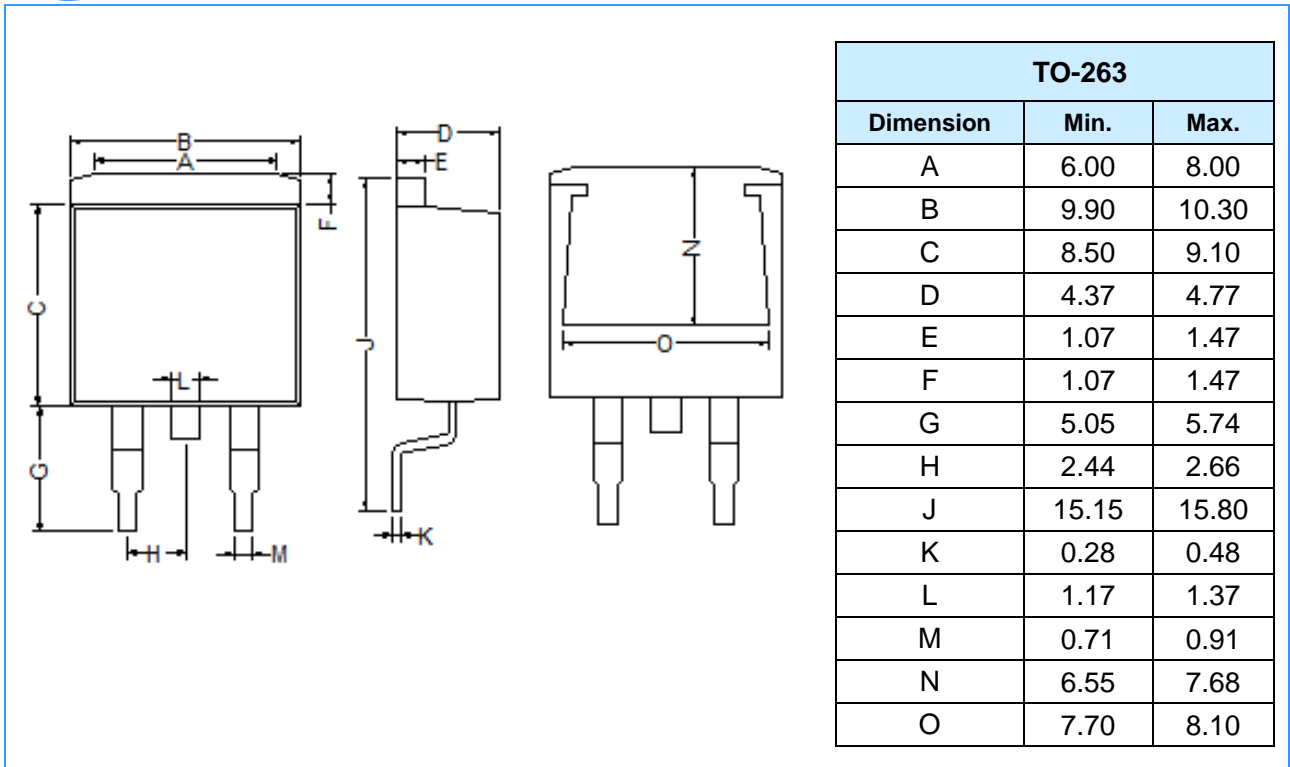


Fig 16 Maximum transient thermal impedance  
(ITO-220AB)

### Package Outline Dimensions (Unit: mm)





**Mounting Pad Layout** (Unit: mm)

